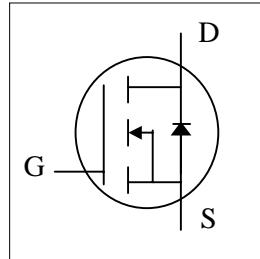
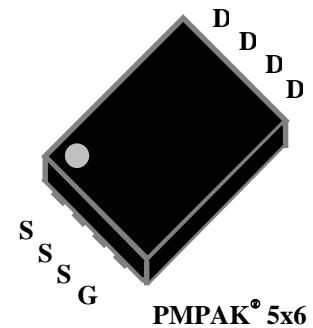




- ▼ Simple Drive Requirement
- ▼ SO-8 Compatible with Heatsink
- ▼ Low On-resistance
- ▼ RoHS Compliant & Halogen-Free



| | |
|--------------|-----|
| BV_{DSS} | 30V |
| $R_{DS(ON)}$ | 9mΩ |
| I_D | 59A |



Description

AP73T03A series are from Advanced Power innovative design and silicon process technology to achieve the lowest possible on-resistance and fast switching performance. It provides the designer with an extreme efficient device for use in a wide range of power applications.

The PMPAK® 5x6 package is special for voltage conversion application using standard infrared reflow technique with the backside heat sink to achieve the good thermal performance.

Absolute Maximum Ratings

| Symbol | Parameter | Rating | Units |
|--------------------------|---|------------|-------|
| V_{DS} | Drain-Source Voltage | 30 | V |
| V_{GS} | Gate-Source Voltage | +20 | V |
| $I_D @ T_C = 25^\circ C$ | Continuous Drain Current (Chip), $V_{GS} @ 10V$ | 59 | A |
| $I_D @ T_A = 25^\circ C$ | Continuous Drain Current ³ | 18.6 | A |
| $I_D @ T_A = 70^\circ C$ | Continuous Drain Current ³ | 14.9 | A |
| I_{DM} | Pulsed Drain Current ¹ | 160 | A |
| $P_D @ T_C = 25^\circ C$ | Total Power Dissipation | 50 | W |
| $P_D @ T_A = 25^\circ C$ | Total Power Dissipation | 5 | W |
| E_{AS} | Single Pulse Avalanche Energy ⁴ | 28.8 | mJ |
| T_{STG} | Storage Temperature Range | -55 to 150 | °C |
| T_J | Operating Junction Temperature Range | -55 to 150 | °C |

Thermal Data

| Symbol | Parameter | Value | Unit |
|-------------|---|-------|------|
| R_{thj-c} | Maximum Thermal Resistance, Junction-case | 2.5 | °C/W |
| R_{thj-a} | Maximum Thermal Resistance, Junction-ambient ³ | 25 | °C/W |



Electrical Characteristics@ $T_j=25^\circ\text{C}$ (unless otherwise specified)

| Symbol | Parameter | Test Conditions | Min. | Typ. | Max. | Units |
|--------------------------|--|---|------|------|-----------|------------------|
| BV_{DSS} | Drain-Source Breakdown Voltage | $V_{\text{GS}}=0\text{V}$, $I_{\text{D}}=250\mu\text{A}$ | 30 | - | - | V |
| $R_{\text{DS(ON)}}$ | Static Drain-Source On-Resistance ² | $V_{\text{GS}}=10\text{V}$, $I_{\text{D}}=20\text{A}$ | - | - | 9 | $\text{m}\Omega$ |
| | | $V_{\text{GS}}=4.5\text{V}$, $I_{\text{D}}=20\text{A}$ | - | - | 16 | $\text{m}\Omega$ |
| $V_{\text{GS(th)}}$ | Gate Threshold Voltage | $V_{\text{DS}}=V_{\text{GS}}$, $I_{\text{D}}=250\mu\text{A}$ | 1 | - | 3 | V |
| g_{fs} | Forward Transconductance | $V_{\text{DS}}=10\text{V}$, $I_{\text{D}}=20\text{A}$ | - | 40 | - | S |
| I_{DSS} | Drain-Source Leakage Current | $V_{\text{DS}}=24\text{V}$, $V_{\text{GS}}=0\text{V}$ | - | - | 10 | μA |
| I_{GSS} | Gate-Source Leakage | $V_{\text{GS}}=\pm 20\text{V}$, $V_{\text{DS}}=0\text{V}$ | - | - | ± 100 | nA |
| Q_g | Total Gate Charge | $I_{\text{D}}=20\text{A}$ | - | 10 | 16 | nC |
| Q_{gs} | Gate-Source Charge | $V_{\text{DS}}=15\text{V}$ | - | 3 | - | nC |
| Q_{gd} | Gate-Drain ("Miller") Charge | $V_{\text{GS}}=4.5\text{V}$ | - | 6 | - | nC |
| $t_{\text{d(on)}}$ | Turn-on Delay Time | $V_{\text{DS}}=15\text{V}$ | - | 9 | - | ns |
| t_r | Rise Time | $I_{\text{D}}=1\text{A}$ | - | 6 | - | ns |
| $t_{\text{d(off)}}$ | Turn-off Delay Time | $R_{\text{G}}=3.3\Omega$ | - | 23 | - | ns |
| t_f | Fall Time | $V_{\text{GS}}=10\text{V}$ | - | 8 | - | ns |
| C_{iss} | Input Capacitance | $V_{\text{GS}}=0\text{V}$ | - | 790 | 1264 | pF |
| C_{oss} | Output Capacitance | $V_{\text{DS}}=15\text{V}$ | - | 250 | - | pF |
| C_{rss} | Reverse Transfer Capacitance | f=1.0MHz | - | 160 | - | pF |
| R_g | Gate Resistance | f=1.0MHz | - | 1.9 | 3.8 | Ω |

Source-Drain Diode

| Symbol | Parameter | Test Conditions | Min. | Typ. | Max. | Units |
|-----------------|---------------------------------|--|------|------|------|-------|
| V_{SD} | Forward On Voltage ² | $I_{\text{S}}=20\text{A}$, $V_{\text{GS}}=0\text{V}$ | - | - | 1.2 | V |
| t_{rr} | Reverse Recovery Time | $I_{\text{S}}=10\text{A}$, $V_{\text{GS}}=0\text{V}$, $dI/dt=100\text{A}/\mu\text{s}$ | - | 21 | - | ns |
| Q_{rr} | Reverse Recovery Charge | | - | 13 | - | nC |

Notes:

- 1.Pulse width limited by Max. junction temperature
- 2.Pulse test
- 3.Surface mounted on 1 in² copper pad of FR4 board, t \leq 10sec, 60°C/W at steady state.
- 4.Starting $T_j=25^\circ\text{C}$, $V_{\text{DD}}=30\text{V}$, $L=0.1\text{mH}$, $R_{\text{G}}=25\Omega$, $I_{\text{AS}}=24\text{A}$.

THIS PRODUCT IS SENSITIVE TO ELECTROSTATIC DISCHARGE, PLEASE HANDLE WITH CAUTION.

USE OF THIS PRODUCT AS A CRITICAL COMPONENT IN LIFE SUPPORT OR OTHER SIMILAR SYSTEMS IS NOT AUTHORIZED.

APEC DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS.

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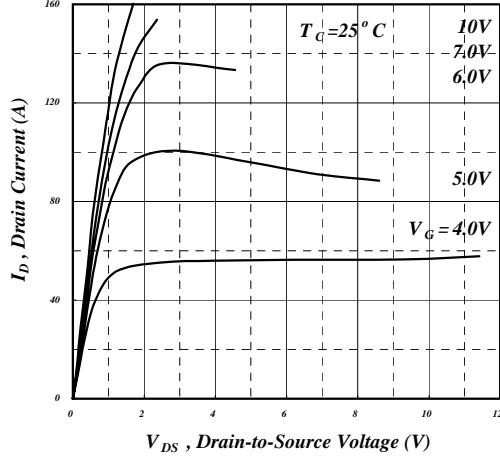


Fig 1. Typical Output Characteristics

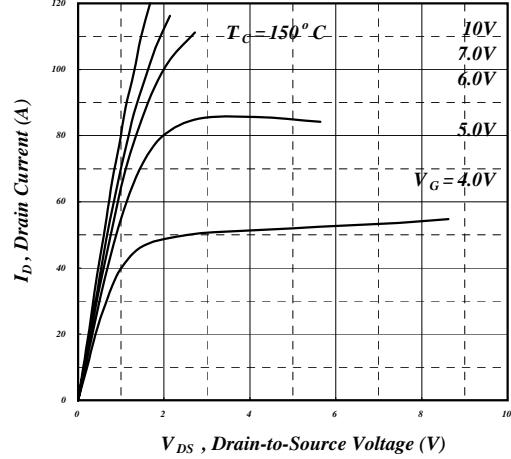


Fig 2. Typical Output Characteristics

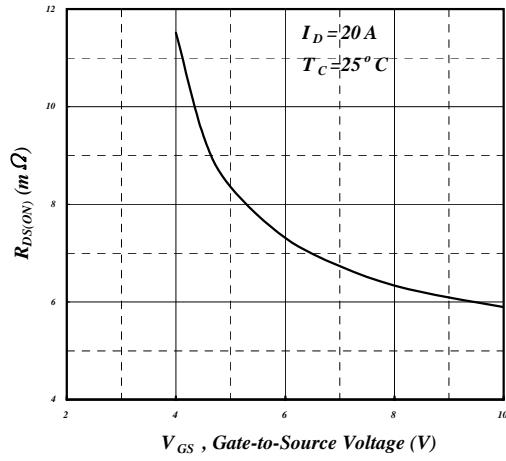


Fig 3. On-Resistance v.s. Gate Voltage

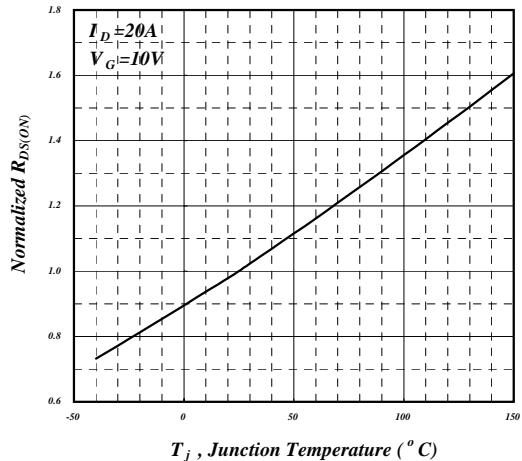


Fig 4. Normalized On-Resistance v.s. Junction Temperature

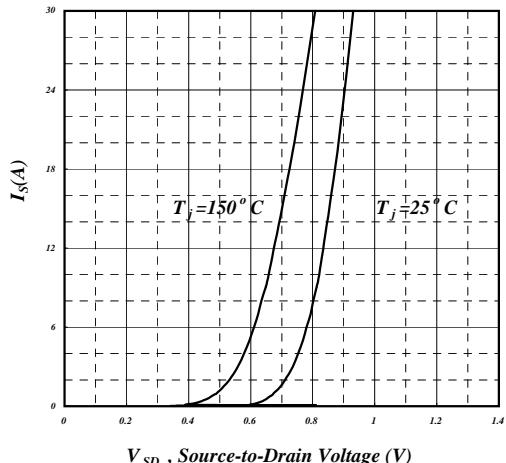


Fig 5. Forward Characteristic of Reverse Diode

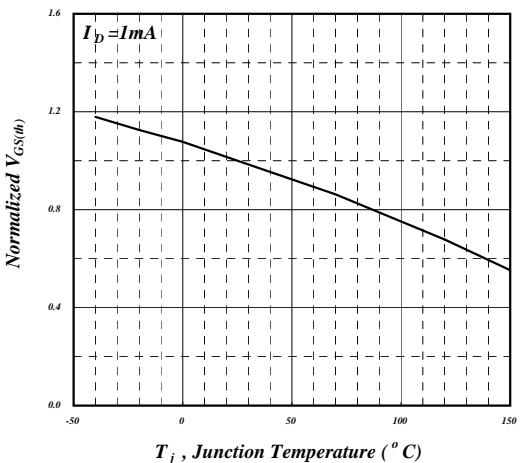


Fig 6. Gate Threshold Voltage v.s. Junction Temperature

